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Application No.	Applicant(s)	
10/749,378_	SHOZO ET AL.	
Examiner	Art Unit	
Philip H Leuna	3742	

SEARCHED			
Class	Subclass	Date	Examiner
219	680-685, 756-757, 751, 400	9/29/2004	P.L.
126	21A, 21R		
99	473-476		
99	451		
N	edated	3/17/05	re

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST searched Inventorship Checked	9/29/2004	P.L.

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